SCDS161A - MAY 2004 - REVISED OCTOBER 2004

- Wide Bandwidth (BW = 350 MHz Min)
- Low Differential Crosstalk  $(X_{TALK} = -68 \text{ dB Typ})$
- Low Power Consumption (I<sub>CC</sub> = 10  $\mu$ A Max)
- **Bidirectional Data Flow, With Near-Zero Propagation Delay**
- Low ON-State Resistance ( $r_{on} = 5 \Omega$  Typ)
- Rail-to-Rail Switching on Data I/O Ports  $(0 \text{ to } V_{CC})$
- V<sub>CC</sub> Operating Range From 3 V to 3.6 V
- Ioff Supports Partial-Power-Down Mode Operation



- **Data and Control Inputs Have Undershoot Clamp Diodes**
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- **ESD Performance Tested Per JESD 22** - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- Suitable for Both 10 Base-T/100 Base-T Signaling



#### description/ordering information

The TI TS3L100 LAN switch is a 4-bit 1-of-2 multiplexer/demultiplexer with a single switch-enable ( $\overline{E}$ ) input. When  $\overline{E}$  is low, the switch is enabled and the I port is connected to the Y port. When  $\overline{E}$  is high, the switch is disabled and the high-impedance state exists between the I and Y ports. The select (S) input controls the data path of the multiplexer/demultiplexer.

TA	PACKAG	ε†	ORDERABLE PART NUMBER	TOP-SIDE MARKING				
	QFN – RGY	Tape and reel	TS3L100RGYR	TK100				
0°C to 70°C		Tube	TS3L100D	T001 400				
	SOIC – D	Tape and reel	TS3L100DR	TS3L100				
	SSOP (QSOP) – DBQ	Tape and reel	TS3L100DBQR	TK100				
		Tube	TS3L100PW	TICADO				
	TSSOP – PW	Tape and reel	TS3L100PWR	TK100				
	TVSOP – DGV	Tape and reel	TS3L100DGVR	TK100				

#### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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#### description/ordering information (continued)

This device can be used to replace mechanical relays in LAN applications. This device has low r<sub>on</sub>, wide bandwidth, and low differential crosstalk, making it suitable for 10 Base-T, 100 Base-T, and various other LAN applications.

This device is fully specified for partial-power-down applications using Ioff. The Ioff feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down,  $\overline{E}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

FUNCTION TABLE							
INP	UTS	INPUT/OUTPUT	FUNCTION				
E	S	YX	FUNCTION				
L	L	IX <sub>0</sub>	$YX = IX_0$				
L	Н	IX <sub>1</sub>	$YX = IX_1$				
Н	Х	Z	Disconnect				

E	S	ΥX	
L	L	IX <sub>0</sub>	$YX = IX_0$
L	Н	IX <sub>1</sub>	$YX = IX_1$
Н	Х	Z	Disconnect

DESCRIPTION						
Data I/Os						
Select input						
Enable input						
Data I/Os						

#### **PIN DESCRIPTIONS**



### logic diagram (positive logic)





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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	–0.5 V to 4.6 V
Control input voltage range, V <sub>IN</sub> (see Notes 1 and 2)	
Switch I/O voltage range, VI/O (see Notes 1, 2, and 3)	
Control input clamp current, I <sub>IK</sub> (V <sub>IN</sub> < 0)	–50 mA
I/O port clamp current, I <sub>I/OK</sub> (V <sub>I/O</sub> < 0)	
ON-state switch current, II/O (see Note 4)	±128 mA
Continuous current through V <sub>CC</sub> or GND terminals	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 5): D package	
DB package	
DBQ package	
PW package	108°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to ground, unless otherwise specified.

- 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- 3. VI and V<sub>O</sub> are used to denote specific conditions for  $V_{I/O}$ .
- 4. II and IO are used to denote specific conditions for  $I_{I/O}$ .
- 5. The package thermal impedance is calculated in accordance with JESD 51-7.

#### recommended operating conditions (see Note 6)

		MIN	MAX	UNIT
VCC	Supply voltage	3	3.6	V
VIH	High-level control input voltage (E, S)	2	V <sub>CC</sub>	V
VIL	Low-level control input voltage (E, S)	0	0.8	V
TA	Operating free-air temperature	0	70	°C

NOTE 6: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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PAR	AMETER		TEST CONDITIONS				MAX	UNIT
VIK	Ē, S	V <sub>CC</sub> = 3 V,	I <sub>IN</sub> = -18 mA				-1.8	V
V <sub>hys</sub>	Ē, S					150		mV
IIН	E, S	V <sub>CC</sub> = 3.6 V,	$V_{IN} = V_{CC}$				±1	μΑ
۱ <sub>IL</sub>	E, S	V <sub>CC</sub> = 3.6 V,	V <sub>IN</sub> = GND				±1	μA
I <sub>OZ</sub> ‡		V <sub>CC</sub> = 3.6 V,	$V_{O} = 0$ to 3.6 V, $V_{I} = 0$ ,	Switch OFF			±1	μΑ
los§		V <sub>CC</sub> = 3.6 V,	$V_{O} = 0$ to 0.5 $V_{CC}$ , $V_{I} = 0$ ,	Switch ON	50			mA
loff		V <sub>CC</sub> = 0,	$V_{O} = 0$ to 3.6 V,	$V_{I} = 0$			15	μΑ
ICC		V <sub>CC</sub> = 3.6 V,	$I_{I/O} = 0,$	Switch ON or OFF		0.1	10	μΑ
∆ICC	Ē, S	V <sub>CC</sub> = 3.6 V,	One input at V <sub>CC</sub> – 0.6 V,	Other inputs at $V_{CC}$ or GND			750	μΑ
ICCD		V <sub>CC</sub> = 3.6 V,	I and Y ports open,	V <sub>IN</sub> input switching 50% duty cycle			0.45	mA/ MHz
CIN	Ē, S	f = 1 MHz				3		pF
~	I port		f = 1 MHz,			5		
COFF	Y port	$V_{  } = 0,$	Outputs open,	Switch OFF		10		pF
CON	-	V <sub>I</sub> = 0,	f = 1 MHz, Outputs open,	Switch ON		17		pF
		$V_{I} = 0 V,$		I <sub>O</sub> = 48 mA		5	7	0
ron		$V_{CC} = 3 V$	V <sub>I</sub> = 2 V,	I <sub>O</sub> = 15 mA		10 15		Ω
∆r <sub>on</sub>		V <sub>I</sub> = 3 V,	Switch ON,	l <sub>O</sub> = 15 mA		1		Ω

# electrical characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V ± 0.3 V (unless otherwise noted)

VI, VO, II, and IO refer to I/O pins. VIN refers to the control inputs.

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V (unless otherwise noted),  $T_A = 25^{\circ}C$ .

<sup>‡</sup> For I/O ports, the parameter I<sub>OZ</sub> includes the input leakage current.

§ The IOS test is applicable to only one ON channel at a time. The duration of this test is less than one second.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V ± 0.3 V, $R_L$ = 100 $\Omega$ , $C_L$ = 35 pF (unless otherwise noted) (see Figure 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	МАХ	UNIT
tON	S	Y	1	7.5	ns
tOFF	S	Y	1	3.5	ns

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V (unless otherwise noted), T<sub>A</sub> = 25°C.

# dynamic characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS					
X <sub>TALK</sub> (Diff)	R <sub>L</sub> = 100 Ω,	f = 10 MHz, see Figure 8,	$t_r = t_f = 2 \text{ ns}$	-55	dB		
X <sub>TALK</sub>	R <sub>L</sub> = 100 Ω,	f = 30 MHz, see Figure 6		-68	dB		
O <sub>IRR</sub>	R <sub>L</sub> = 100 Ω,	f = 30 MHz, see Figure 7		-42	dB		
BW	$R_L$ = 100 Ω, see Fig	gure 5		350	MHz		

<sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C.



## TS3L100 **QUAD SPDT WIDE-BANDWIDTH LAN SWITCH** WITH LOW ON-STATE RESISTANCE SCDS161A - MAY 2004 - REVISED OCTOBER 2004



Figure 1. Gain/Phase vs Frequency



## **TS3L100** QUAD SPDT WIDE-BANDWIDTH LAN SWITCH WITH LOW ON-STATE RESISTANCE SCDS161A - MAY 2004 - REVISED OCTOBER 2004



Figure 2. Off Isolation vs Frequency



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Figure 3. Crosstalk vs Frequency



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#### PARAMETER MEASUREMENT INFORMATION



TEST	Vcc	RL	CL	V <sub>X0</sub>	V <sub>X1</sub>
tON	$\begin{array}{c} 3.3 \ V \pm 0.3 \ V \\ 3.3 \ V \pm 0.3 \ V \end{array}$	100 Ω 100 Ω	35 pF 35 pF	GND 3 V	3 V GND
tOFF	$\begin{array}{c} 3.3 \ V \pm 0.3 \ V \\ 3.3 \ V \pm 0.3 \ V \end{array}$	100 Ω 100 Ω	35 pF 35 pF	GND 3 V	3 V GND



NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
- C. The outputs are measured one at a time, with one transition per measurement.

#### Figure 4. Test Circuit and Voltage Waveforms



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#### PARAMETER MEASUREMENT INFORMATION



Figure 5. Test Circuit for Frequency Response (BW)

Frequency response is measured at the output of the ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at IA<sub>0</sub>. All unused analog I/O ports are left open.

#### HP8753ES setup

Average = 4RBW = 3 kHz $V_{BIAS} = 0.35 V$ ST = 2 sP1 = 0 dBM



#### PARAMETER MEASUREMENT INFORMATION



 $^{\dagger}$  A 50- $\!\Omega$  termination resistor is needed for the network analyzer.

#### Figure 6. Test Circuit for Crosstalk (XTALK)

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when  $V_S = 0$ ,  $V_E = 0$ , and YA is the input, the output is measured at IB<sub>0</sub>. All unused analog input (Y) ports are connected to GND and output (I) ports are connected to GND through 50- $\Omega$  pulldown resistors.

#### HP8753ES setup

Average = 4 RBW = 3 kHz  $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM



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#### PARAMETER MEASUREMENT INFORMATION



<sup>†</sup>A 50- $\Omega$  termination resistor is needed for the network analyzer.

#### Figure 7. Test Circuit for Off Isolation (OIRR)

OFF isolation is measured at the output of the OFF channel. For example, when  $V_S = V_{CC}$ ,  $V_E = 0$ , and YA is the input, the output is measured at IA<sub>0</sub>. All unused analog input (Y) ports are left open and output (I) ports are connected to GND through 50- $\Omega$  pulldown resistors.

#### HP8753ES setup

Average = 4RBW = 3 kHz $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM



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### PARAMETER MEASUREMENT INFORMATION





Differential crosstalk is a measure of coupling noise between a transmit and receive pair in the LAN application. Differential crosstalk depends on the edge rate, frequency, and load. This is calculated from the equation,  $X_{TALK}(Diff) db = 20 \log V_O(Diff)/V_I(Diff)$ , where  $V_O(Diff)$  is the differential output voltage and  $V_I(Diff)$  is the differential input voltage.



#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Packag Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TS3L100D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100DBQR	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
TS3L100DBQRE4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
TS3L100DE4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100DGVR	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100DGVRE4	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100DRE4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100PWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100PWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3L100RGYR	ACTIVE	QFN	RGY	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

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<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## **MECHANICAL DATA**

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

#### DGV (R-PDSO-G\*\*)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012 variation AC.



## **MECHANICAL DATA**



Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.

F. Package complies to JEDEC MO-241 variation BB.



DBQ (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AB.



## **MECHANICAL DATA**

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

## PW (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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